## Application/Control No. Applicant(s)/Patent Under Reexamination 10/630,898 HWANG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2186 Pierre-Michel Bataille **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,763,418 07-2004 Chou et al. 710/317 Α \* В US-6,108,756 08-2000 Miller et al. 711/148 С US-5,751,638 05-1998 Mick et al. 365/189.04 US-D US-Ε F US-G US-Н US-US-US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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